

Notice of References Cited	Application/Control No. 10/758,983	Applicant(s)/Patent Under Reexamination YAMAKAWA ET AL.	
	Examiner Patricia T Nguyen	Art Unit 2817	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,696,903 B1	02-2004	Kawahara et al.	333/134
	C	US-6,411,176 B1	06-2002	Atokawa et al.	333/132
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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